

<b>Notice of References Cited</b>	Application/Control No. 10/707,388	Applicant(s)/Patent Under Reexamination DIVAKARUNI ET AL.	
	Examiner Steven J. Fulk	Art Unit 2891	Page 1 of 2

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	Examiner Steven J. Fulk	Art Unit 2891	Page 2 of 2

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	L	US-			
	M	US-			

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